Se	arch	Notes	;

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/083,134	HEINONEN ET AL.	
Examiner	Art Unit	
Azizul Choudhury	2145	

SEARCHED			
Subclass	Date	Examiner	
	<u> </u>		
	-		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
709	USPGPUB	12/7/2006	AC

. SEARCH I (INCLUDING SEAR			)
		DATE	EXMR
EAST (Search Updated)		12/7/2006	AC
	-		